



PATENT Conf. No.: 2526

THE UNITED STATES PATENT OFFICE

Applicants:

Vasisht Mantra Vadi, et al.

Assignee:

Xilinx, Inc.

Title:

"Segmented Dataline Scheme in a Memory with Enhanced Full

Fault Coverage Memory Cell Testability"

Serial No.:

10/796,750

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Examiner:

Trong Q. Phan

Art Unit:

2827

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Mail Stop RCE COMMISSIONER FOR PATENTS P.O. Box 1450

Alexandria, Virginia 22313-1450

AMENDMENT FILED WITH AN RCE

Dear Sir:

Please amend the above-identified application as indicated beginning on the following page.

Amendments to the Claims are reflected in the listing of claims which begins on page 2 of this paper.

Remarks begin on page 11 of this paper.